

DEBUG IN HIGH DEFINITION



HDO4000A

200 MHz – 1 GHz
Oscilloscopes



Lowest Noise and
Powerful Toolbox

HD4096 Technology

Superior User Experience

Powerful, Deep Toolbox

Exceptional Serial Data Tools

The HDO4000A with HD4096 Technology provides exceptional signal fidelity with 12-bit resolution and a superior oscilloscope experience to deliver faster time to insight.

DEBUG IN HIGH DEFINITION

High Definition Oscilloscopes with HD Technology have a variety of benefits that allow the user to debug in high definition. Waveforms displayed by High Definition Oscilloscopes are cleaner and crisper. More signal details can be seen and measured; these measurements are made with unmatched precision resulting in better test results and shorter debug time.



Experience HD4096 accuracy, detail, and precision and never use an 8-bit oscilloscope again. Whether the application is general-purpose design and debug, high-precision analog, power electronics, automotive electronics, mechatronics, or other specialized applications, the HD4096 technology provides unsurpassed confidence and measurement capabilities.

Clean, Crisp Waveforms

When compared to waveforms acquired and displayed using conventional 8-bit oscilloscopes, waveforms captured with HD4096 12-bit technology are dramatically crisper and cleaner, and are displayed more accurately.

More Signal Details

16x more resolution provides more signal detail. This is especially helpful for wide dynamic range signals in which a full-scale signal must be acquired while at the same time very small amplitude signal details must be analyzed.

Unmatched Measurement Precision

HD4096 technology delivers measurement precision several times better than conventional 8-bit oscilloscopes. Higher oscilloscope measurement precision provides better ability to assess corner cases and design margins, perform root cause analysis, and create the best possible solution for any discovered design issue.



| | HDO4000A | HDO6000A | HDO8000A | HDO9000 |
|-------------------|---------------------------|--------------------|--------------------|--------------------|
| HD Technology | HD4096 12 bits | HD4096 12 bits | HD4096 12 bits | HD1024 10 bits |
| Bandwidth | 200 MHz - 1 GHz | 350 MHz - 1 GHz | 350 MHz - 1 GHz | 1 GHz - 4 GHz |
| Input Channels | 4 | 4 | 8 | 4 |
| Sample Rate | 10 GS/s | 10 GS/s | 10 GS/s | 40 GS/s |
| Standard Toolbox | Basic | Advanced | Advanced | Advanced |
| Serial Data Tools | TD | TDME | TDME | TDME, SDAII, QPHY |
| User Experience | MAUI with OneTouch | MAUI with OneTouch | MAUI with OneTouch | MAUI with OneTouch |



HD1024 technology provides 10 bits of vertical resolution with 4 GHz bandwidth. As with all members of Teledyne LeCroy's HDO family, the HDO9000 utilizes an exceptionally low-noise system architecture that delivers

outstanding effective number of bits (ENOB). Dynamic ADC Configuration permits the ADC to be set to 8, 9, or 10 bits. Optimized filtering provides additional resolution beyond 10 bits (extending up to 13.8 bits).



DEBUG IN HIGH DEFINITION

Lowest Noise and
Powerful Toolbox

HDO4000A

HD4096

High Definition
Technology

High Signal to
Noise Input
Amplifiers

High Sample
Rate 12-bit
ADC's

HD
4096

Low Noise
System
Architecture

HD4096
technology
enables 12 bits of
vertical resolution
with 1 GHz bandwidth

- Clean, Crisp Waveforms
- More Signal Details
- Unmatched Measurement Precision



Deep Toolbox

OBSESSED WITH TOOLS

HDO4000A has the greatest breadth and depth of tools, ensuring quick resolution of the most complicated debug tasks.



The HDO4000A with **HD4096 Technology** provides **exceptional signal fidelity** with 12-bit resolution and a **superior oscilloscope experience** to deliver **faster time to insight**.

- 1 HD4096 Technology
- 2 Superior User Experience
- 3 Powerful, Deep Toolbox
- 4 Exceptional Serial Data Tools



**Faster
Time to
Insight**

Insight alone is not enough.

Markets and **technologies** change too rapidly.

The **timing** of **critical design decisions** is significant.

Faster Time to Insight is what matters.



MAUI® – SUPERIOR USER EXPERIENCE



MAUI – Most Advanced User Interface was developed to put all the power and capabilities of the modern oscilloscope right at your fingertips. Designed for touch; all important oscilloscope controls are accessed through the intuitive touch screen. Built for simplicity; time saving shortcuts and intuitive dialogs simplify setup. Made to solve; a deep set of debug and analysis tools helps identify problems and find solutions quickly.

Designed for Touch

MAUI is designed for touch. Operate the oscilloscope just like a phone or tablet with the most unique touch screen features on any oscilloscope. All important controls are always one touch away. Touch the waveform to position or zoom in for more details using intuitive actions.

Built for Simplicity

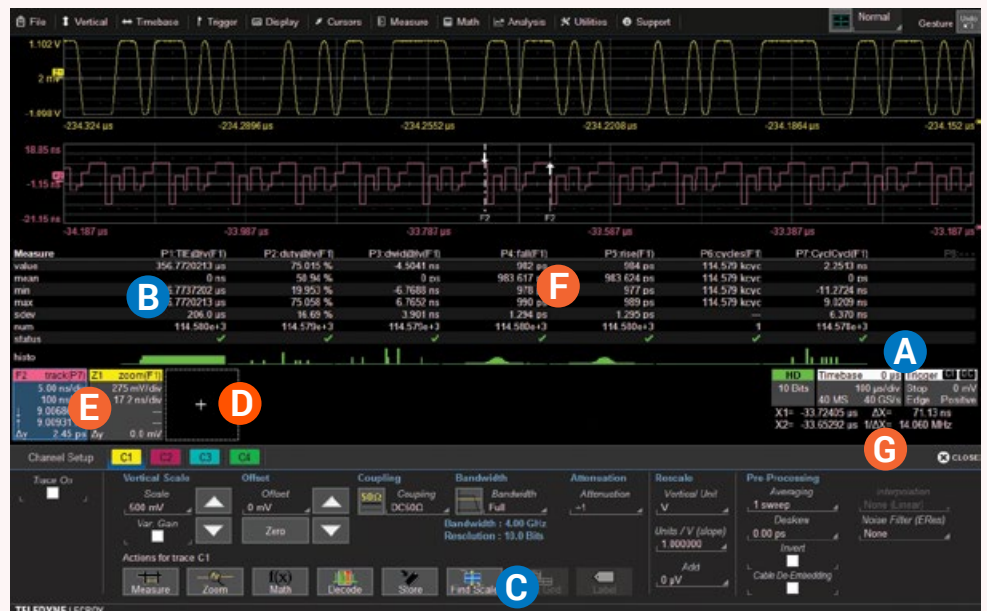
MAUI is built for simplicity. Basic waveform viewing and measurement tools as well as advanced math and analysis capabilities are seamlessly integrated in a single user interface. Time saving shortcuts and intuitive dialogs simplify setup and shorten debug time.

Made to Solve

MAUI is made to solve. A deep set of integrated debug and analysis tools help identify problems and find solutions quickly. Unsurpassed integration provides critical flexibility when debugging. Solve problems fast with powerful analysis tools.

MAUI with OneTouch

MAUI with OneTouch introduces a new paradigm for oscilloscope user experience. Dramatically reduce setup time with revolutionary drag and drop actions to copy and setup channels, math functions, and measurement parameters without lifting a finger. Use common gestures like drag, drop, and flick to instinctively interact with the oscilloscope. Quickly enable a new channel, math or measurement using the “Add New” button and simply turn off any trace with a flick of the finger. These OneTouch innovations provide unsurpassed efficiency in oscilloscope operation.



- A** Channel, timebase, and trigger descriptors provide easy access to controls without navigating menus.
- B** Configure parameters by touching measurement results.
- C** Shortcuts to commonly used functions are displayed at the bottom of the channel, math and memory menus.
- D** Use the “Add New” button for one-touch trace creation.
- E** Drag to change source, copy setup, turn on new trace, or move waveform location.
- F** Drag to copy measurement parameters to streamline setup process.
- G** Drag to quickly position cursors on a trace.

POWERFUL, DEEP TOOLBOX

| Capture | | View | | | Measure | Math | | Analyze | | | | | | | | | | Document |
|------------|---------|---------------|---------------|---------|------------|--------------------|-----------|--------------------|-----------|-------------------|---------------|-------------------------|-----------------------|--------------------|----------------------|----------------------|----------|----------|
| Triggering | Acquire | Display Grids | Display Views | Zooming | Parameters | Parameter Analysis | Functions | Advanced Functions | Pass/Fail | Anomaly Detection | Serial Decode | Serial Message Analysis | Clock & Timing Jitter | Serial Data Jitter | Serial Data Analysis | Application Packages | Document | |
| 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 | 16 | 17-22 | 23 | |
| 24 | 25 | 26 | 27 | 28 | 29 | 30 | 31 | 32 | 33 | 34 | 35 | 36 | 37 | 38 | 39 | 40-45 | 46 | |
| 47 | 48 | 49 | 50 | 51 | 52 | 53 | 54 | 55 | 56 | 57 | 58 | 59 | 60 | 61 | 62 | 63-67 | 68 | |
| 69 | 70 | 71 | 72 | 73 | 74 | 75 | 76 | 77 | 78 | 79 | 80 | 81 | 82 | 83 | 84 | 85-89 | 90 | |
| 91 | 92 | 93 | 94 | 95 | 96 | 97 | 98 | 99 | 100 | 101 | 102 | 103 | 104 | 105 | 106 | 107-114 | 115 | |
| 117 | 118 | 119 | 120 | 121 | 122 | 123 | 124 | 125 | 126 | 127 | 128 | 129 | 130 | 131 | 132 | 133 | 134 | |
| 137 | 138 | 139 | 140 | 141 | 142 | 143 | 144 | 145 | 146 | 147 | 148 | 149 | 150 | 151 | 152 | 153 | 154 | |

KEY

Element: 106 ▲ Invented by LeCroy ★ Unique to LeCroy

Category: Crosstalk Analysis

Number: 106

MAUI Icon:

Name: Crosstalk Analysis

Our Heritage

Teledyne LeCroy's 50+ year heritage has its origins in the high-speed collection of data in the field of high-energy physics, and the processing of long records to extract meaningful insight. We didn't invent the oscilloscope, but we did invent the digital oscilloscope, which can take full advantage of advanced digital signal processing and waveshape analysis tools to provide unparalleled insight.

Our Obsession

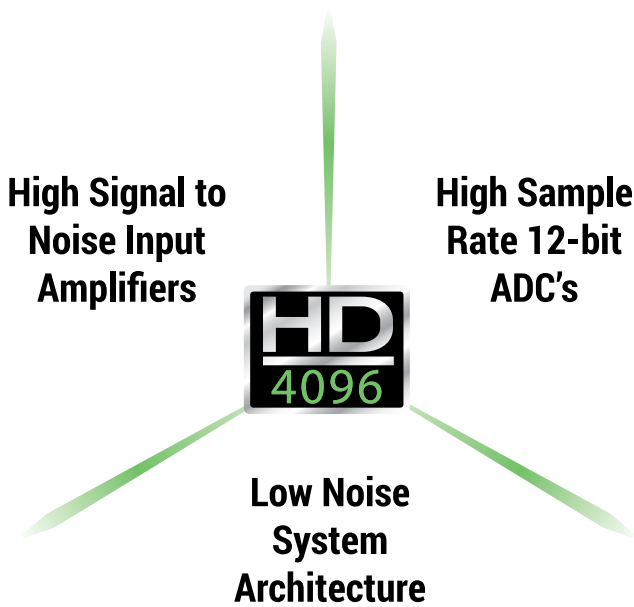
Our developers are true to our heritage – they are more obsessed with making better and smarter tools than anybody else. Our tools and operating philosophy are standardized across much of our product line for a consistent user experience. Our mission is to help you use these tools to understand problems, including the ones you don't even know you have. Our deep toolbox inspires insight; and your moment of insight is our reward.

Our Invitation

Our Periodic Table of Oscilloscope Tools provides a framework to understand the toolsets that Teledyne LeCroy has created and deployed in our oscilloscopes. Visit our interactive website to learn more about what we offer and how we can help you develop and debug more efficiently.

teledynelecroy.com/tools

HD4096 TECHNOLOGY – 16X CLOSER TO PERFECT

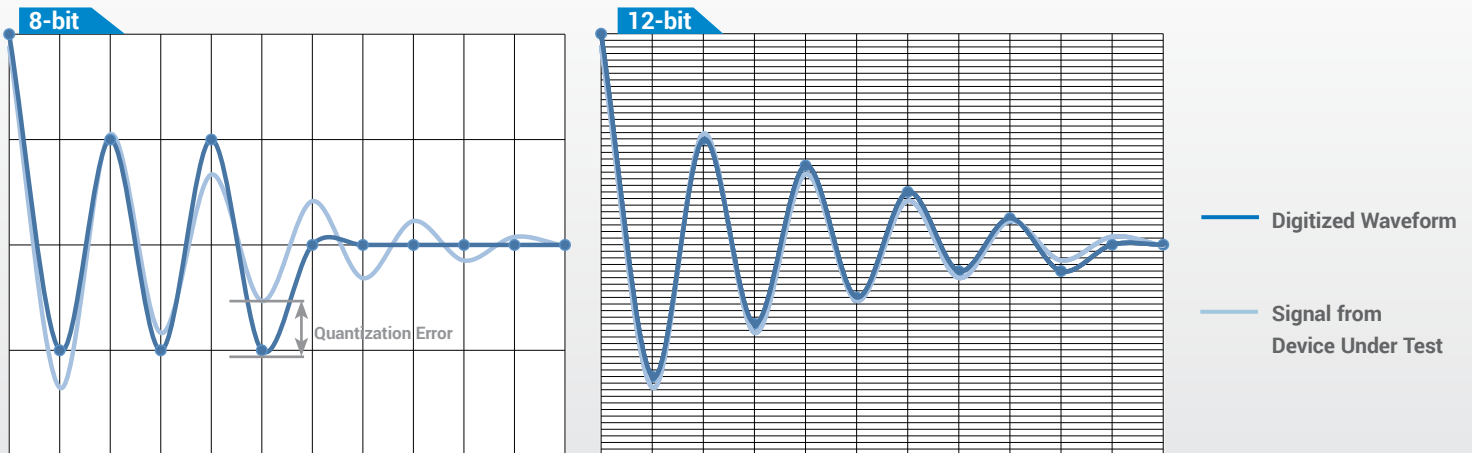


Teledyne LeCroy HDO high definition oscilloscopes use unique HD4096 technology to provide superior and uncompromised measurement performance:

- 12-bit ADCs with high sample rates
- High signal-to-noise amplifiers (55 dB)
- Low noise system architecture (to 1 GHz)

Oscilloscopes with HD4096 technology have higher resolution than conventional 8-bit oscilloscopes (4096 vs. 256 vertical levels) and low noise for uncompromised measurement performance. The 12-bit ADCs support capture of fast signals and oscilloscope bandwidth ratings up to 1 GHz, and Enhanced Sample Rate to 10 GS/s ensures the highest measurement accuracy and precision. The high performance input amplifiers deliver pristine signal fidelity with a 55 dB signal-to-noise ratio. The low-noise system architecture provides an ideal signal path to ensure that signal details are delivered accurately to the oscilloscope display – 16x closer to perfect.

16x Closer to Perfect



16x More Resolution

HD4096 technology provides 12-bits of vertical resolution with 16x more resolution compared to conventional 8-bit oscilloscopes. The 4096 discrete vertical levels reduce the quantization error compared to 256 vertical levels. This improves the accuracy and precision of the signal capture and increases measurement confidence.

EXPERIENCE THE DIFFERENCE



Experience HD4096 accuracy, detail, and precision and never use an 8-bit oscilloscope again. Whether the application is general-purpose design and debug, high-precision analog, power electronics, automotive electronics, mechatronics, or other specialized applications, the HD4096 technology provides unsurpassed confidence and measurement capabilities.

Clean, Crisp Waveforms

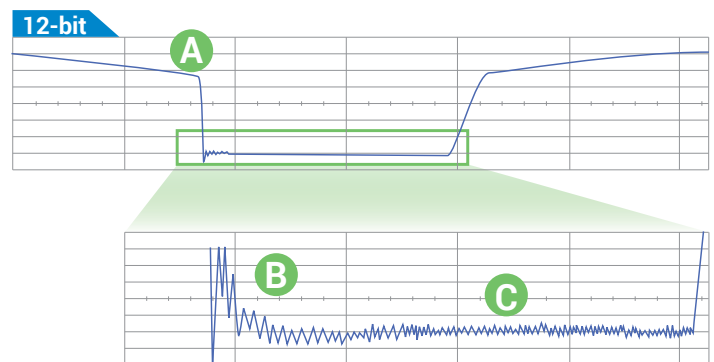
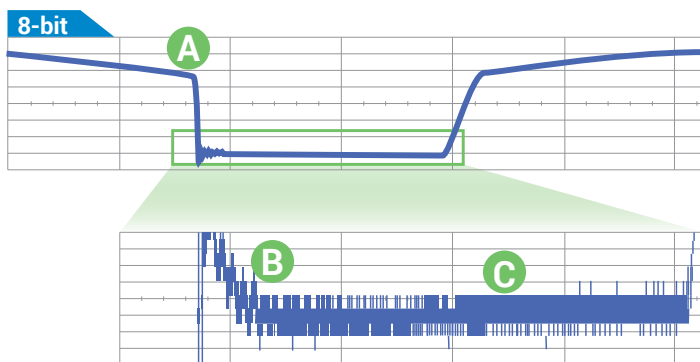
When compared to waveforms acquired and displayed using conventional 8-bit oscilloscopes, waveforms captured with HD4096 12-bit technology are dramatically crisper and cleaner, and are displayed more accurately. Once you see a waveform acquired with HD4096 technology, you will not want to go back to using a conventional 8-bit oscilloscope.

More Signal Details

16x more resolution provides more signal detail. This is especially helpful for wide dynamic range signals in which a full-scale signal must be acquired while at the same time very small amplitude signal details must be analyzed. 12-bit acquisitions combined with the oscilloscope's vertical and horizontal zoom can be used to obtain unparalleled insight to system behaviors and problems.

Unmatched Measurement Precision

HD4096 technology delivers measurement precision several times better than conventional 8-bit oscilloscopes. Higher oscilloscope measurement precision provides better ability to assess corner cases and design margins, perform root cause analysis, and create the best possible solution for any discovered design issue.



- A Clean, Crisp Waveforms** | Thin traces show the actual waveform with minimal noise interference
- B More Signal Details** | Waveform details lost on an 8-bit oscilloscope can now be clearly seen
- C Unmatched Measurement Precision** | Measurements are more precise and not affected by quantization noise

HDO4000A oscilloscopes have 4 analog input channels, 12-bit resolution using Teledyne LeCroy's HD4096 high definition technology, up to 1 GHz of bandwidth and a compact form factor with a large 12.1" multi-touch display. They are ideal for debug and troubleshooting of power electronics designs, digital power management or power integrity analysis, automotive electronics systems, and deeply embedded or mechatronic designs.

Key Features

4 analog channels

12-bit ADC resolution, up to
15-bit with enhanced resolution

200 MHz, 350 MHz, 500 MHz and
1 GHz bandwidths

Long Memory – up to 50 Mpts

Multi-language User Interface

WaveScan - Search and Find

LabNotebook Documentation and
Report Generation

History Mode

Spectrum Analyzer Mode

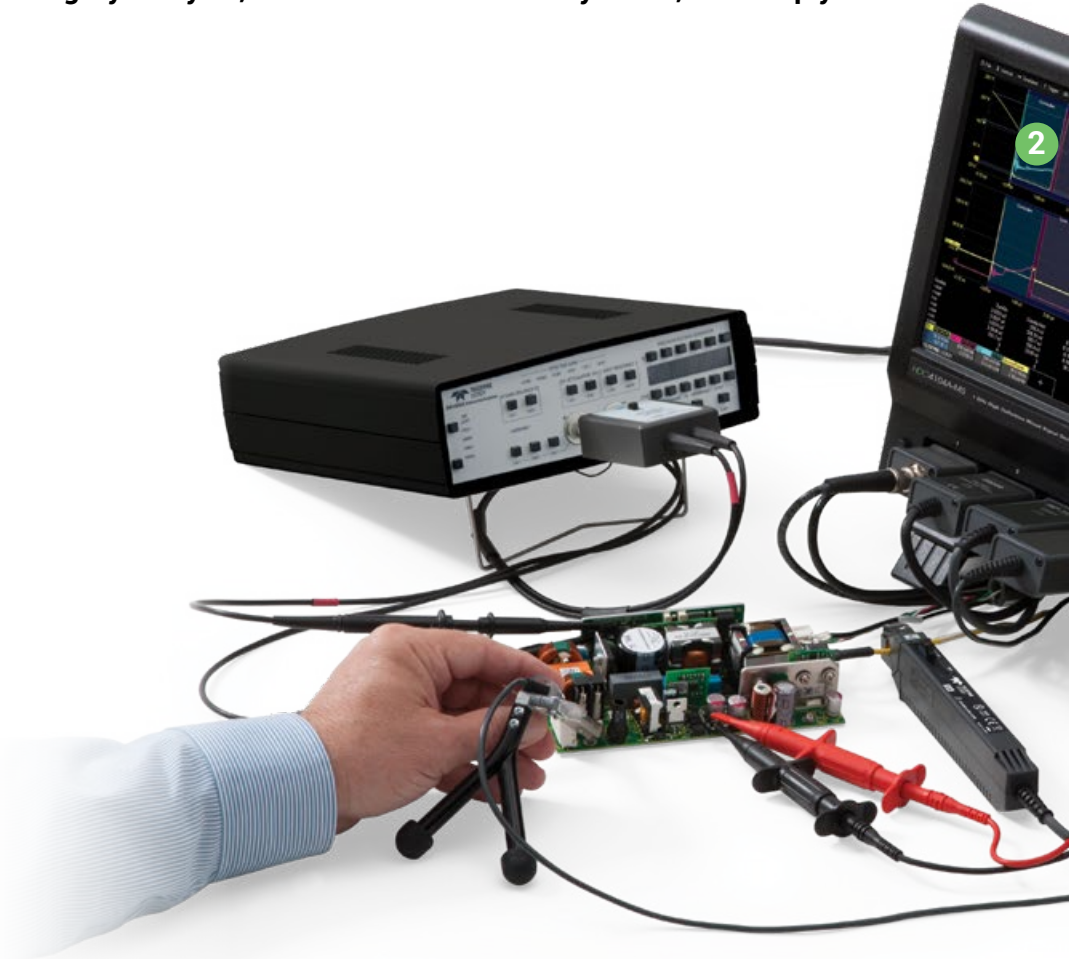
Power Analysis Software

16 Digital Channel MSO option

Serial Trigger and Decode options

12.1" WXGA multi-touch screen display

**Wide probe selection for power
electronics, embedded electronics,
and mechatronics applications**



Power Electronics

Measure single-device(s), half, or Full/H-bridge outputs, including gate-drive voltages. Measure device loss or switch-mode power supply power or control loop performance, including line harmonics. The best performing HV probes support full characterization of all aspects of the power conversion system.

Automotive Electronics

Automotive electronic control units (ECUs) are tested to stringent standards. 12-bits and 250 Mpts provides the amplitude and time resolution needed for better and more intuitive cause-effect analog signal analysis. Deep digital logic capture and extensive serial data toolsets provides an all-in-one characterization tool for the complex, dynamic behavior of the vehicle ECUs.



Digital Power Management, Power Integrity

12-bit accuracy and precision and 1 GHz of bandwidth is perfect for transient rail response, rail voltage power integrity, crosstalk and harmonics evaluation. Specialized probes, analysis software, and serial decoders make fast work of complex embedded system power management and integrity validation.

Deeply Embedded and Mechatronic Systems

Today's consumer appliances and industrial systems combine complex embedded controls, power electronics, and sensors to achieve the highest efficiency and provide important control and other benefits. Time-to-market, cost and quality pressures place exceptional demands on new product test, debug and troubleshooting.

- 1 Only 13 cm (5") Deep – The most space-efficient oscilloscope for your bench from 200 MHz to 1 GHz
- 2 12.1" Widescreen (16 x 9) high resolution WXGA color multi-touch screen display.
- 3 Built-in stylus for touch screen
- 4 Local language user interface front panel overlay
- 5 "Push" Knobs – All knobs have push functionality that provides shortcuts to common actions such as Set to Variable, Find Trigger Level, Zero Offset, and Zero Delay
- 6 Waveform Control Knobs for channel, zoom, math and memory traces
- 7 Dedicated buttons to quickly access popular debug tools
- 8 Easy connectivity with two convenient USB ports on the front, two on the side
- 9 Mixed Signal Capability - Debug complex embedded designs with integrated 16 channel mixed signal capability
- 10 Rotating and Tilting Feet provide 4 different viewing positions
- 11 Auxiliary Output and Reference Clock Input/Output connectors for connecting to other equipment
- 12 USBTMC (Test and Measurement Class) port simplifies programming

The HDO4000A High Definition Oscilloscopes offer powerful mixed signal solutions that combine high definition analog channels with the flexibility of digital inputs. The HDO4000A-MS options provide an integrated 16 digital channels and a 1.25 GS/s sampling rate to create an all-in-one debug machine.

Integrated 16-Channel Mixed Signal Capability

With embedded systems growing more complex, powerful mixed signal debug capabilities are an essential part of modern oscilloscopes. The 16 integrated digital channels and set of tools designed to view, measure and analyze analog and digital signals enable fast debugging of mixed signal designs.

Extensive Triggering

Flexible analog and digital cross-pattern triggering across all 20 channels provides the ability to quickly identify and isolate problems in an embedded system. Event triggering can be configured to arm on an analog signal and trigger on a digital pattern.

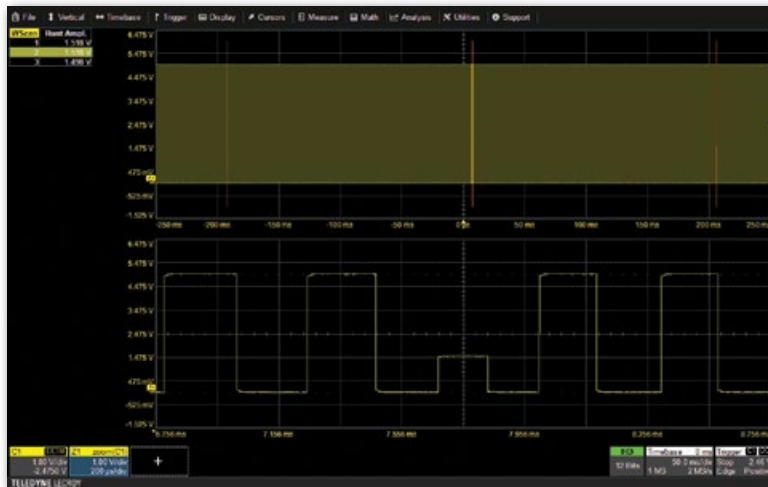
Advanced Digital Debug Tools

Using the powerful parallel pattern search capability of WaveScan, patterns across many digital lines can be isolated and analyzed. Identified patterns are presented in a table with timestamp information and enables quick searching for each pattern occurrence.

Use a variety of the many timing parameters to measure and analyze the characteristics of digital busses. Powerful tools like tracks, trends, statistics and histograms provide additional insight and help find anomalies.

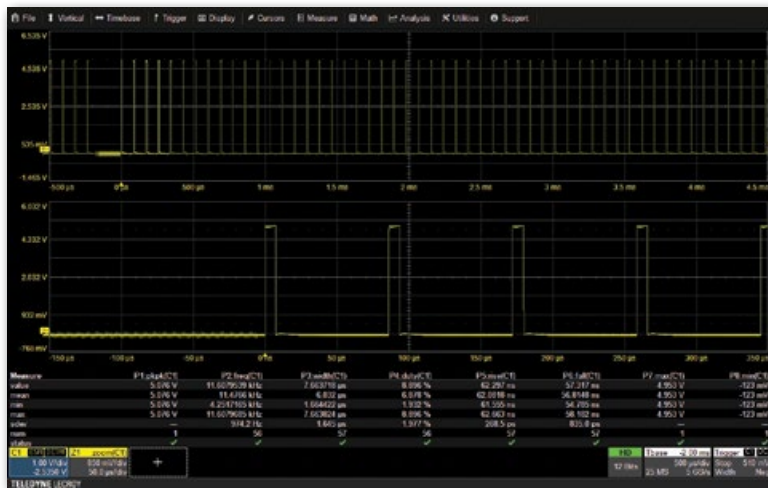
Quickly see the state of all the digital lines at the same time using convenient activity indicators.





WaveScan Advanced Search

WaveScan provides powerful isolation capabilities that hardware triggers can't provide. WaveScan allows searching analog, digital or parallel bus signal in a single acquisition using more than 20 different criteria. Or, set up a scan condition and scan for an event over hours or even days.



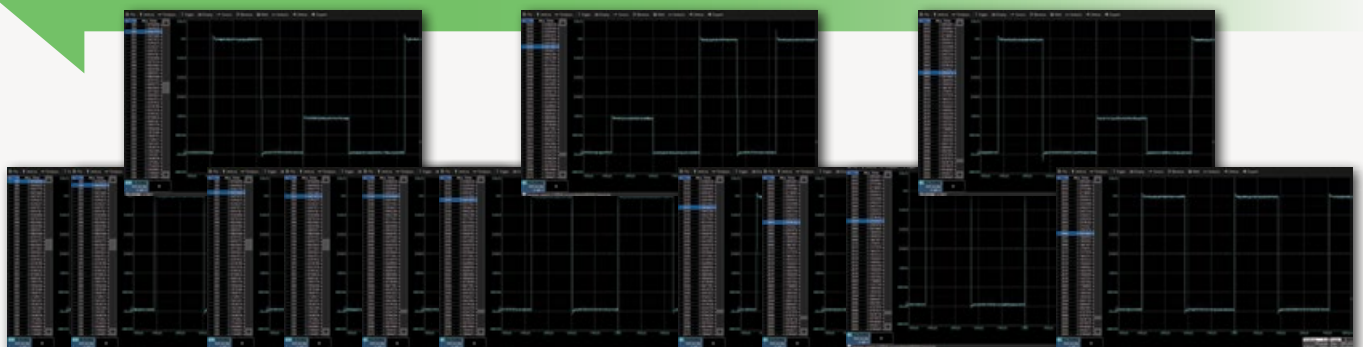
Advanced Math and Measure

With many math functions and measurement parameters available, the HDO4000A can measure and analyze every aspect of analog and digital waveforms. By utilizing HD4096 technology, the HDO4000A measures 16 times more precisely than traditional 8-bit architectures. Additionally, the HDO4000A provides statistics, histograms and trends to show how waveforms change over time.

History Mode Waveform Playback

Scroll back in time using History Mode to view previous waveforms and isolate anomalies. Use cursors and measurement parameters to quickly find the source of problems. History mode is always available with a single button press, no need to enable this mode and never miss a waveform.

Go Back in Time to Identify the Source of a Problem



EXCEPTIONAL SERIAL DATA TOOLS

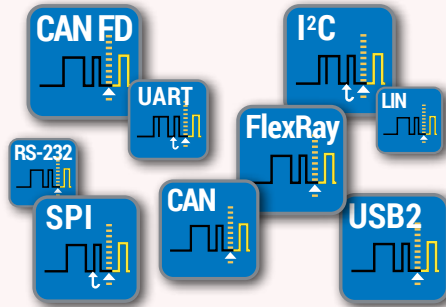
The HDO4000A features the widest range and most complete serial data debug toolsets.

- Triggering
- Decoding

HDO4000A Serial Data Protocol Support

| | | Trigger | Decode |
|-------------------------|---------------------------------------|---------|--------|
| Embedded Computing | I ² C | • | • |
| | SPI | • | • |
| | UART-RS232 | • | • |
| | USB2-HSIC | | • |
| Automotive + Industrial | CAN | • | • |
| | CAN FD | • | • |
| | FlexRay | • | • |
| | LIN | • | • |
| | SENT | | • |
| Avionics | ARINC429 | | • |
| | MIL-STD-1553 | • | • |
| | SPACEWIRE | | • |
| Computing + Peripherals | Ethernet (10/100Base-T) | | • |
| | MDIO | | • |
| | USB 1.1/2.0 | • | • |
| | 8b/10b | • | • |
| | D-PHY/CSI-2/DSI | | • |
| MIPI | DigRF3G | | • |
| | DigRFv4 | | • |
| Other | SPMI | | • |
| | Audio (I ² S, LJ, RJ, TDM) | • | • |
| | Manchester | | • |
| | NRZ | • | • |

T D



Trigger

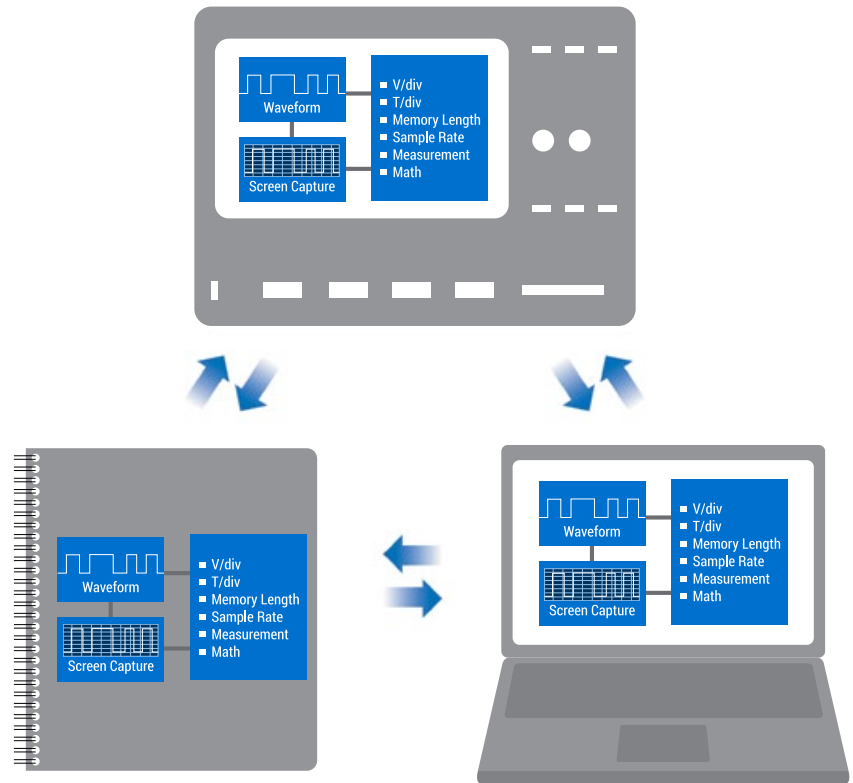
Powerful, flexible triggers designed by people who know the standards, with the unique capabilities you want to isolate unusual events. Conditional data triggering permits maximum flexibility and highly adaptable error frame triggering is available to isolate error conditions. Efficiently acquire bursted data using Sequence Mode to maximize the oscilloscope's memory usage. Sequence Mode enables the oscilloscope to ignore idle time and acquire only data of interest.

Decode

Decoded protocol information is color-coded to specific portions of the serial data waveform and transparently overlaid for an intuitive, easy-to-understand visual record. All decoded protocols are displayed in a single time-interleaved table. Touch a row in the interactive table to quickly zoom to a packet of interest and select a column header to create filter criteria, as is commonly done in spreadsheets. Easily search through long records for specific protocol events using the built-in search feature.

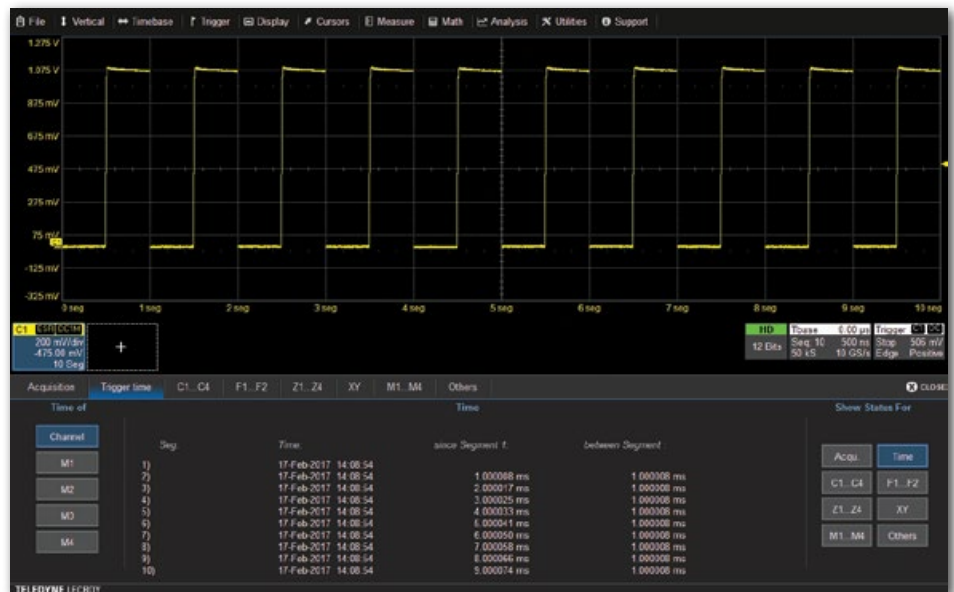
LabNotebook Documentation Tool

LabNotebook is a standard feature of HDO4000A and is the ideal documentation tool. LabNotebook automatically saves all displayed waveforms, oscilloscope setup file, and a screen image with a single button press, eliminating the need to navigate multiple menus to save all these files independently. Report files can be annotated and shared with colleagues to fully document all results. Easily recreate experiments and compare tests results amongst colleagues across the world by recalling LabNotebook files back onto the oscilloscope or view on a PC using WaveStudio.



Advanced Waveform Capture with Sequence Mode

Use Sequence mode to store up to 10,000 triggered events as segments. This is ideal when capturing fast pulses in quick succession or when capturing events separated by long time periods. Each segment has a timestamp and dead-time between triggers is less than 1 μ s. Isolate rate events over time by combining with advanced triggers.



Key Features

Spectrum analyzer style controls for the oscilloscope

Dual Spectrum Capability

Select from six vertical scales (in dB, V, or A)

Automatic frequency peak identifications

Display up to 20 markers, with interactive table readout of frequencies and levels

Easily make measurements with reference and delta markers

Automatically identify and mark fundamental frequency and harmonics

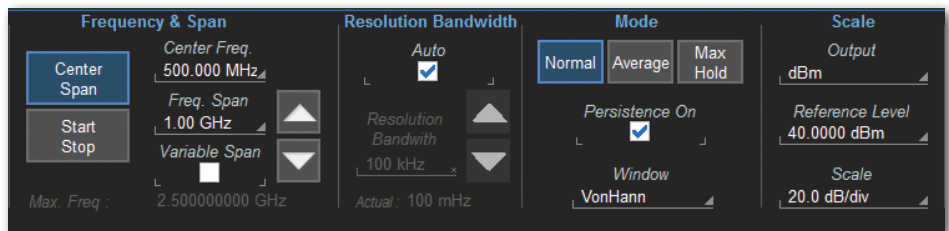
Spectrogram shows how spectra changes over time in 2D or 3D views



Use two independent input settings and frequency ranges for advanced spectrum analysis.

Simplify Analysis of FFT Power Spectrum

Get faster and better insight to the frequency content of any signal with use of the Spectrum Analyzer mode on the HDO4000A. This mode provides a spectrum analyzer style user interface with controls for start/stop frequency or center frequency and span. The resolution bandwidth is automatically set for best analysis or can be manually selected. Peak search automatically labels spectral components and presents frequency and level in an interactive table. Utilize up to 20 markers to automatically identify harmonics and quickly analyze frequency content by making measurements between reference and delta markers. Spectrograms display a 2D or 3D history of the frequency content to provided insight into how the spectrum changes over time.



Spectrum analyzer style controls simplify waveform analysis in the frequency domain.

POWER ANALYSIS OPTION



Key Features

Automated measurement zone identification with color-coded overlays

Control loop and time domain response analysis

Line power and harmonics tests to IEC 61000-3-2

Total harmonic distortion table shows frequency contribution

B-H Curve shows magnetic device saturation

Power Analyzer Automates Switching Device Loss Measurements

Quickly measure and analyze the operating characteristics of power conversion devices and circuits with the Power Analyzer option. Critical power switching device measurements, control loop modulation analysis, and line power harmonic testing are all simplified with a dedicated user interface and automatic measurements. Areas of turn-on, turn-off, and conduction loss are all identified with color-coded waveform overlays for faster analysis.

Power Analyzer provides quick and easy setup of voltage and current inputs and makes measurements as simple as the push of a button. Tools are provided to help reduce sources of measurement errors and the measurement parameters provide details of single cycle or average device power losses.

Beyond the advanced power loss measurement capabilities, the Power Analyzer modulation analysis capabilities provide insight to understand control loop response to critical events such as a power supply's soft start performance or step response to line and load changes. The Line Power Analysis tool allows simple and quick pre-compliance testing to EN 61000-3-2.

Teledyne LeCroy offers an extensive range of probes to meet virtually every probing need.

ZS Series High Impedance Active Probes

ZS1000, ZS1000-QUADPAK
ZS1500, ZS1500-QUADPAK



High input impedance (1 MΩ), low 0.9 pF input capacitance and an extensive set of probe tips and ground accessories make these low-cost single-ended probes ideal for a wide range of applications. The ZS Series is available up to 4 GHz bandwidth.

Differential Probes (200 MHz – 1.5 GHz)

ZD1500, ZD1000,
ZD500, ZD200
AP033



High bandwidth, excellent common-mode rejection ratio (CMRR) and low noise make these active differential probes ideal for applications such as automotive electronics and data communications. AP033 provides 10x gain for high-sensitivity measurement of series/shunt resistor voltages.

Active Voltage/Power Rail Probe

RP4030



Specifically designed to probe a low impedance power/voltage rail. The RP4030 has 30V built-in offset adjust, low attenuation (noise), and high DC input impedance with 4 GHz of bandwidth and a wide assortment of tips and leads, including solder-in and U.FL receptacle connections.

High Voltage Fiber Optically-isolated Probe

HVFO103



The HVFO103 is a compact, simple, affordable probe for measurement of small signals (gate-drives, sensors, etc.) floating on an HV bus in power electronics designs, or for EMC, EFT, ESD, and RF immunity testing sensor monitoring. Suitable for up to 35kV common-mode. 140 dB CMRR.

HVD Series High Voltage Differential Probes

HVD3102, HVD3106 (1 kV)
HVD3206 (2 kV)
HVD3605 (6 kV)



Available with 1, 2 or 6kV common-mode ratings. Excellent CMRR (65 dB @ 1 MHz) at high frequencies is combined with low inherent noise, wide differential voltage range, high offset voltage capabilities, and 1% gain accuracy. The ideal probe for power conversion system test.

High Voltage Passive Probes

HVP120,
PPE4KV, PPE5KV, PPE6KV



The HVP and PPE Series includes four fixed-attenuation probes covering a range from 1 kV to 6 kV. These probes are ideal for lightning/surge or EFT testing, or for probing in-circuit beyond the range of a LV-rate passive probe.

Differential Amplifier

DA1855A
DXC100A, DXC200
DXC-5100, DA101



The DA1855A is a stand-alone high performance 100 MHz differential amplifier with 100 dB CMRR and HV common-mode when combined with a suitable probe pair (sold separately). It is ideal for semiconductor device conduction/switching loss or high sensitivity voltage measurements.

Current Probes

CP030, CP030-3M, CP030A
CP031, CP031A
CP150, CP150-6M
CP500, DCS015



Available in bandwidths up to 100 MHz with peak currents of 700 A and sensitivities to 1 mA/div. Extra-long cables (3 or 6 meters) available on some models. Ideal for component or power conversion system input/output measurements. DCS015 deskew calibration source also available.

Probe and Current Sensor Adapters

TPA10, TPA10-QUADPAK
CA10, CA10-QUADPAK



TPA10 adapts supported Tektronix TekProbe-compatible probes to Teledyne LeCroy ProBus interface. CA10 is a programmable adapter for third-party current sensors that have voltage or current outputs proportional to measured current. QUADPAKs of four pieces each are available.

| Vertical - Analog Channels | HDO4024A HDO4024A-MS | HDO4034A HDO4034A-MS | HDO4054A HDO4054A-MS | HDO4104A HDO4104A-MS |
|--|--|---|---|--|
| Bandwidth @ 50 Ω (-3 dB) | 200 MHz | 350 MHz | 500 MHz | 1 GHz |
| Rise Time (10–90%, 50 Ω) | 1.75 ns | 1 ns | 700 ps | 450 ps |
| Input Channels | 4 | | | |
| Vertical Resolution | 12-bits; up to 15-bits with enhanced resolution (ERES) | | | |
| Effective Number of Bits (ENOB) | 8.8 bits | 8.7 bits | 8.6 bits | 8.4 bits |
| Vertical Noise Floor | | | | |
| 1 mV/div | 70 μVrms | 85 μVrms | 100 μVrms | 145 μVrms |
| 2 mV/div | 70 μVrms | 85 μVrms | 100 μVrms | 145 μVrms |
| 5 mV/div | 75 μVrms | 90 μVrms | 105 μVrms | 150 μVrms |
| 10 mV/div | 80 μVrms | 95 μVrms | 110 μVrms | 155 μVrms |
| 20 mV/div | 100 μVrms | 110 μVrms | 130 μVrms | 185 μVrms |
| 50 mV/div | 195 μVrms | 210 μVrms | 265 μVrms | 275 μVrms |
| 100 mV/div | 340 μVrms | 360 μVrms | 450 μVrms | 500 μVrms |
| 200 mV/div | 1.00 mVrms | 1.10 mVrms | 1.25 mVrms | 1.75 mVrms |
| 500 mV/div | 1.90 mVrms | 2.10 mVrms | 2.60 mVrms | 2.75 mVrms |
| 1 V/div | 3.40 mVrms | 3.70 mVrms | 4.50 mVrms | 4.90 mVrms |
| Sensitivity | 50 Ω: 1 mV/div–1 V/div, fully variable; 1 MΩ: 1 mV/div–10 V/div, fully variable | | | |
| DC Vertical Gain Accuracy (Gain Component of DC Accuracy) | ±(0.5%) F.S, offset at 0 V | | | |
| Channel-Channel Isolation | DC-200 MHz: 60 dB (>1000:1), (For any two input channels, same V/div settings, typical) | DC-200 MHz: 60 dB (>1000:1), 200 MHz up to rated BW: 50 dB (>300:1), (For any two input channels, same V/div settings, typical) | DC-200 MHz: 60 dB (>1000:1), 200 MHz up to rated BW: 50 dB (>300:1), (For any two input channels, same V/div settings, typical) | DC-200 MHz: 60 dB (>1000:1), 200-500 MHz: 50 dB (>300:1), 500 MHz up to rated bandwidth: 40 dB (>100:1) (For any two input channels, same V/div settings, typical) |
| Offset Range | 50 Ω: 1 mV - 4.95 mV: ±1.6 V, 5 mV - 9.9 mV: ±4 V, 10 mV - 19.8 mV: ±8 V, 20 mV - 1 V: ±10 V 1 MΩ: 1 mV - 4.95 mV: ±1.6 V, 5 mV - 9.9 mV: ±4 V, 10 mV - 19.8 mV: ±8 V, 20 mV - 100 mV: ±16 V, 102 mV - 198 mV: ±80V, 200 mV - 1 V: ±160 V, 1.02 V - 10 V: ±400 V | | | |
| DC Vertical Offset Accuracy | ±(1.0% of offset setting + 0.5%FS + 0.02% of max offset + 1mV) | | | |
| Maximum Input Voltage | 50 Ω: 5 Vrms, 1 MΩ: 400 V max (DC + Peak AC ≤ 10 KHz) | | | |
| Input Coupling | 50 Ω: DC, GND; 1 MΩ: AC, DC, GND; | | | |
| Input Impedance | 50 Ω ± 2.0%; 1 MΩ ± 2.0% 16 pF, | | | |
| Bandwidth Limiters | 20 MHz, 200 MHz | | | |

Horizontal - Analog Channels

| | |
|--------------------------------------|--|
| Acquisition Modes | Real-time, Roll, Random Interleaved Sampling (RIS), Sequence |
| Time/Division Range | 200 ps/div - 1.25 ks/div with standard memory (up to 2.5 ks/div with -L memory); RIS available at ≤ 10 ns/div; Roll Mode available at ≥ 100 ms/div and ≤ 5 MS/s |
| Clock Accuracy | ±2.5 ppm + 1.0ppm/year from calibration |
| Sample Clock Jitter | Up to 10 ms acquired time range: 280 fsrms (internal timebase reference) |
| Delta Time Measurement Accuracy | $\sqrt{2} * \sqrt{\left(\frac{\text{Noise}}{\text{SlewRate}}\right)^2 + (\text{Sample Clock Jitter})^2 \text{ (RMS)} + (\text{clock accuracy} * \text{reading}) \text{ (seconds)}}$ |
| Jitter Measurement Floor | $\sqrt{\left(\frac{\text{Noise}}{\text{SlewRate}}\right)^2 + (\text{Sample Clock Jitter})^2 \text{ (RMS, seconds, TIE)}}$ |
| Jitter Between Channels | Analog Channels: 2 psrms (TIE, typical); Digital Channels: 350 ps (maximum) between any two channels Analog-Digital Channels: <5ns (maximum) between any analog and any digital channel |
| Channel-Channel Deskew Range | ±9 x time/div. setting, 100 ms max., each channel |
| External Timebase Reference (Input) | 10 MHz ±25 ppm at 0 to 10 dBm into 50 Ω |
| External Timebase Reference (Output) | 10 MHz, 2.0 dBm ±1.5 dBm, sinewave synchronized to reference being used (internal or external reference) |

Acquisition - Analog Channels

| | |
|----------------------------------|--|
| Sample Rate (Single-shot) | 10 GS/s on all 4 Channels with Enhanced Sample Rate |
| Sample Rate (Repetitive) | 125 GS/s, user selectable for repetitive signals (20 ps/div to 10 ns/div) |
| Memory Length | Standard: 12.5 Mpts/ch for all channels, 25 Mpts (interleaved) (10,000 segments) |
| (# of Segments in Sequence Mode) | Option - L: 25 Mpts/ch for all channels, 50 Mpts (interleaved) (10,000 segments) |
| Intersegment Time | 1 μs |
| Averaging | Summed averaging to 1 million sweeps; continuous averaging to 1 million sweeps |
| Enhanced Resolution (ERES) | From 12.5- to 15-bits vertical resolution |
| Envelope (Extrema) | Envelope, floor, or roof for up to 1 million sweeps |
| Interpolation | Linear or Sin x/x (2 pt and 4 pt); 5 or 10 GS/s Enhanced Sample Rate defaults to 2 pt or 4 pt Sin x/x respectively |

HDO4024A
HDO4024A-MS

HDO4034A
HDO4034A-MS

HDO4054A
HDO4054A-MS

HDO4104A
HDO4104A-MS

Vertical, Horizontal, Acquisition - Digital Channels (with HDO4000A-MS only)

| | | | | |
|--------------------------------|--|---|--|--|
| Input Channels | 16 Digital Channels | | | |
| Threshold Groupings | Pod 2: D15 - D8, Pod 1: D7 - D0 | | | |
| Threshold Selections | TTL, ECL, CMOS (2.5 V, 3.3 V, 5 V), PECL, LVDS or User Defined | | | |
| Maximum Input Voltage | ±30V Peak | | | |
| Threshold Accuracy | ±(3% of threshold setting + 100mV) | | | |
| Input Dynamic Range | ± 20V | | | |
| Minimum Input Voltage Swing | 400mV | | | |
| Input Impedance (Flying Leads) | 100 kΩ 5 pF | | | |
| Maximum Input Frequency | 250 MHz | | | |
| Sample Rate | 1.25 GS/s | | | |
| Record Length | Standard: | 12.5 MS (25 MS interleaved) - 16 Channels | | |
| | Optional -L: | 25 MS (50 MS interleaved) - 16 Channels | | |
| Minimum Detectable Pulse Width | 2 ns | | | |
| Channel-to-Channel Skew | 350 ps | | | |
| User Defined Threshold Range | ±10 V in 20 mV steps | | | |
| User Defined Hysteresis Range | 100 mV to 1.4 V in 100 mV steps | | | |

Triggering System

| | | | | |
|--|---|--|--|--|
| Modes | Normal, Auto, Single, and Stop | | | |
| Sources | Any input channel, External, Ext/10, or line; slope and level unique to each source (except for line trigger) | | | |
| Coupling | DC, AC, HFRej, LFRej | | | |
| Pre-trigger Delay | 0-100% of memory size (adjustable in 1% increments of 100 ns) | | | |
| Post-trigger Delay | 0-10,000 Divisions in real time mode, limited at slower time/div settings or in roll mode | | | |
| Hold-off | From 2 ns up to 20 s or from 1 to 99,999,999 events | | | |
| Trigger and Interpolator Jitter | ≤ 4 ps rms (typical) | ≤ 4 ps rms (typical) | ≤ 3.5 ps rms (typical) | ≤ 3.5 ps rms (typical) |
| Internal Trigger Level Range | ±4.1 div from center (typical) | | | |
| External Trigger Input Range | Ext: ±400 mV, Ext/10: ±4 V | | | |
| Maximum Trigger Rate | 1,000,000 waveforms/sec (in Sequence Mode, up to 4 channels) | | | |
| Trigger Sensitivity with Edge Trigger (Ch 1-4) | 0.9 division: 10 MHz 1.0 divisions: 200 MHz | 0.9 division: 10 MHz 1.0 divisions: 200 MHz 2.0 divisions: 350 MHz | 0.9 division: 10 MHz 1.0 divisions: 200 MHz 1.5 divisions: 250 MHz 2.0 divisions: 500 MHz | 0.9 division: 10 MHz 1.0 divisions: 200 MHz 1.5 divisions: 500 MHz 2.0 divisions: 1 GHz |
| Trigger Sensitivity with Edge Trigger (External Input) | 0.9 division: 10 MHz 1.0 divisions: 200 MHz 2 | 0.9 division: 10 MHz 1.0 divisions: 200 MHz 2.0 divisions: 350 MHz | 0.9 division: 10 MHz 1.0 divisions: 200 MHz 1.5 divisions: 250 MHz 2.0 divisions: 500 MHz | 0.9 division: 10 MHz 1.0 divisions: 200 MHz 1.5 divisions: 500 MHz 2.0 divisions: 1 GHz |
| Max. Trigger Frequency, Smart Trigger | 200 MHz | 350 MHz | 500 MHz | 1 GHz |

Trigger Types

| | |
|--|--|
| Edge | Triggers when signal meets slope (positive, negative, or either) and level condition |
| Width | Triggers on positive or negative glitches with selectable widths. Minimum width 1.5ns, Maximum width: 20 s |
| Glitch | Triggers on positive or negative glitches with selectable widths. Minimum width 1.5ns, Maximum width: 20 s |
| Window | Triggers when signal exits a window defined by adjustable thresholds |
| Pattern | Logic combination (AND, NAND, OR, NOR) of up to 5 inputs (4 channels and external trigger input). Each source can be high, low, or don't care. The High and Low level can be selected independently. Triggers at start or end of the pattern. |
| TV-Composite Video | Triggers NTSC or PAL with selectable line and field; HDTV (720p, 1080i, 1080p) with selectable frame rate (50 or 60 Hz) and Line; or CUSTOM with selectable Fields (1-8), Lines (up to 2000), Frame Rates (25, 30, 50, or 60 Hz), Interlacing (1:1, 2:1, 4:1, 8:1), or Synch Pulse Slope (Positive or Negative) |
| Runt | Trigger on positive or negative runts defined by two voltage limits and two time limits. Select between 1 ns and 20 ns |
| Slew Rate | Trigger on edge rates. Select limits for dV, dt, and slope. Select edge limits between 1 ns and 20 ns |
| Interval | Triggers on intervals selectable between 1 ns and 20 s |
| Dropout | Triggers if signal drops out for longer than selected time between 1 ns and 20 s |
| Triggers with Exclusion Technology | Glitch, Width, Interval, Runt, Slew Rate - Trigger on intermittent faults by specifying the expected behavior and triggering when that condition is not met |
| Qualified (Timeout or State/Edge Qualified) | Triggers on any input source only if a defined state or edge occurred on another input source. Delay between sources is selectable by time or events. (Note: event B pattern trigger cannot include analog channels). |
| Low Speed Serial Protocol Trigger (Optional) | I2C, SPI (SPI, SSPI, SIOP), UART-RS232, CAN1.1, CAN2.0, CAN FD, LIN, FlexRay, MIL-STD-1553, AudioBus (I2S, LJ, RJ, TDM), USB1.x/2.0 |

HDO4024A
HDO4024A-MS

HDO4034A
HDO4034A-MS

HDO4054A
HDO4054A-MS

HDO4104A
HDO4104A-MS

Measurement Tools

| | |
|--|--|
| Measurement Functionality | Display up to 8 measurement parameters together with statistics, including mean, minimum, maximum, standard deviation, and total number. Each occurrence of each parameter is measured and added to the statistics table. . Histicons provide a fast, dynamic view of parameters and wave shape characteristics. Parameter gates define the location for measurement on the source waveform. |
| Measurement Parameters - Horizontal + Jitter | Delay (from trigger, 50%), Duty Cycle (50%, @level), Edges (@level), Fall Time (90-10, 20-80), Frequency (50%, @level), Period (50%, @level), Δ Period (@level), Phase (@level), Rise Time (10-90, 20-80), Skew, Time (@level), Δ Time (@level), Width+, Width- |
| Measurement Parameters - Vertical | Amplitude, Base, Maximum, Mean, Minimum, Peak-to-Peak, RMS, Std. Deviation, Top. |
| Measurement Parameters - Pulse | Area, Base, Fall Time (90-10, 80-20), Overshoot (positive, negative), Rise Time (10-90, 80-20), Top, Width+, Width- |

Math Tools

| | |
|-------------------------------------|--|
| Math Functionality | Display up to 2 math functions traces (F1-F2). The easy-to-use graphical interface simplifies setup of up to two operations on each function trace, and function traces can be chained together to perform math-on-math. |
| Math Operators - Basic Math | Average (summed), Average (continuous), Difference (-), Envelope, Floor, Invert (negate), Product (x), Ratio (/), Reciprocal, Rescale (with units), Roof, Sum (+). |
| Math Operators - Filters | Enhanced resolution (to 15 bits vertical) |
| Math Operators - Frequency Analysis | FFT (power spectrum, magnitude), up to full record length. Select from Rectangular, VonHann, Hamming, FlatTop and Blackman Harris windows. |
| Math Operators - Functions | Absolute value, Derivative, Integral, Invert (negate), Reciprocal, Rescale (with units), Square, Square root, Zoom (identity). |

Measurement and Math Integration

Trend (datalog) of up to 1 million measurement parameters.

Pass/Fail Testing

| | |
|-------------------|---|
| Pass/Fail Testing | Mask Test (pre-defined or user-defined mask, waveform All In, All Out, Any In, or Any Out conditions) with following THEN Save (waveforms), Stop, Alarm, (send) Pulse, Hardcopy (send email, save screen image, save to clipboard, send to printer), or (save) LabNotebook. |
|-------------------|---|

Display System

| | |
|-------------------------|---|
| Display Size | Color 12.1" widescreen flat panel TFT-Active Matrix with high resolution touch screen |
| Display Resolution | WXGA; 1280 x 800 pixels |
| Number of Traces | Display a maximum of 8 traces. Simultaneously display channel, zoom, memory, math, and X-Y traces |
| Grid Styles | Auto, Single, Dual, Quad, Octal, Tandem, Quattro, X-Y, Single+X-Y, Dual+X-Y |
| Waveform Representation | Sample dots joined, or sample dots only |

HDO4024A HDO4024A-MS

HDO4034A HDO4034A-MS

HDO4054A HDO4054A-MS

HDO4104A HDO4104A-MS

Processor/CPU

| | |
|---------------------------------|---|
| Type | Intel® Core™ i3-2330E Dual, 2.2 GHz (or better) |
| Processor Memory | 8 GB standard standard |
| Operating System | Microsoft Windows® 7 Pro 64-Bit Embedded |
| Oscilloscope Operating Software | Teledyne LeCroy MAUI™ with OneTouch |

Connectivity

| | |
|-----------------------|--|
| Ethernet Port | Supports 2 10/100/1000BaseT Ethernet interface (RJ45 ports) |
| USB Host Ports | Minimum 6 total (incl. 2 front panel) USB 2.0 ports support Windows compatible devices |
| USB Device Port | 1 USBTMC port |
| GPIO Port (Optional) | Supports IEEE – 488.2 (External) |
| External Monitor Port | DVI connector, HDMI connector and 15 pin D-Type WXGA compatible DB-15 to support customer-supplied external monitor. Includes support for extended desktop operation with WXGA resolution on second monitor. Supports touch screen integration of external monitor (Note: external display can not use a Fujitsu touch-screen driver). |
| Remote Control | Via Windows Automation, or via Teledyne LeCroy Remote Command Set |

Probes

| | |
|-----------------|---|
| Standard Probes | Qty. (4) ±10 Passive Probes |
| Probing System | ProBus. Automatically detects and supports a variety of compatible probes |

Power Requirements

| | |
|-----------------------------|--|
| Voltage | 100–240 VAC ±10% at 45-66 Hz; 110-120 VAC ±10% at 380-420 Hz; Automatic AC Voltage Selection; Installation Category 300 V CAT II |
| Power Consumption (Nominal) | 200 W / 200 VA |
| Max Power Consumption | 320 W / 320 VA (with all PC peripherals and active probes connected to 4 channels) |

Environmental

| | |
|------------------|--|
| Temperature | Operating: 5 °C to 40 °C; Non-Operating: -20 °C to 60 °C |
| Humidity | Operating: 5% to 90% relative humidity (non-condensing) up to +31 °C, Upper limit derates to 50% relative humidity (non-condensing) at +40 °C; Non-Operating: 5% to 95% relative humidity (non-condensing) as tested per MIL-PRF-28800F |
| Altitude | Operating: 3,048 m (10,000 ft) max at +30 °C; Non-Operating: Up to 12,192 meters (40,000 ft) |
| Random Vibration | Operating : 0.31 g _{rms} 5 Hz to 500 Hz, 15 minutes in each of three orthogonal axes; Non-Operating: 2.4 g _{rms} 5 Hz to 500 Hz, 15 minutes in each of three orthogonal axes |
| Functional Shock | 30 g _{peak} , half sine, 11 ms pulse, 3 shocks (positive and negative) in each of three orthogonal axes, 18 shocks total |

Physical

| | |
|------------------|--|
| Dimensions (HWD) | 11.48"H x 15.72"W x 5.17"D (291.7 mm x 399.4 mm x 131.31 mm) |
| Weight | 12.9 lbs. (5.86 kg.) |

Certifications

| | |
|--|--|
| CE Certification UL and cUL Listing | CE Compliant, UL and cUL listed, confirms to: UL 61010-1 (3rd Edition), UL 61010-2-030 (1st Edition) CAN/CSA C22.2 No.61010-1-12 |
| | CE Compliant, UL and cUL listed, confirms to: UL 61010-1 (3rd Edition), UL 61010-2-030 (1st Edition) CAN/CSA C22.2 No.61010-1-12 |

Warranty and Service

3-year warranty; calibration recommended annually. Optional service programs include extended warranty, upgrades, and calibration services

ORDERING INFORMATION



| Product Description | Product Code |
|---|--------------|
| HDO4000A Oscilloscopes | |
| 200 MHz, 10 GS/s, 4 Ch, 12.5 Mpts/Ch 12-bit HD Oscilloscope with 12.1" WXGA Touch Display | HDO4024A |
| 350 MHz, 10 GS/s, 4 Ch, 12.5 Mpts/Ch 12-bit HD Oscilloscope with 12.1" WXGA Touch Display | HDO4034A |
| 500 MHz, 10 GS/s, 4 Ch, 12.5 Mpts/Ch 12-bit HD Oscilloscope with 12.1" WXGA Touch Display | HDO4054A |
| 1 GHz, 10 GS/s, 4 Ch, 12.5 Mpts/Ch 12-bit HD Oscilloscope with 12.1" WXGA Touch Display | HDO4104A |

| Product Description | Product Code |
|--|--------------|
| HDO4000A-MS Mixed Signal Oscilloscopes | |
| 200 MHz, 10 GS/s, 4+16ch, 12.5 Mpts/Ch 12-bit HD Mixed Signal Oscilloscope w/ 12.1" WXGA Color Display | HDO4024A-MS |
| 350 MHz, 10 GS/s, 4+16ch, 12.5 Mpts/Ch 12-bit HD Mixed Signal Oscilloscope w/ 12.1" WXGA Color Display | HDO4034A-MS |
| 500 MHz, 10 GS/s, 4+16ch, 12.5 Mpts/Ch 12-bit HD Mixed Signal Oscilloscope w/ 12.1" WXGA Color Display | HDO4054A-MS |
| 1 GHz, 10 GS/s, 4+16ch, 12.5 Mpts/Ch 12-bit HD Mixed Signal Oscilloscope w/ 12.1" WXGA Color Display | HDO4104A-MS |

Included with Standard Configurations (HDO4000A and HDO4000A-MS)
 ±10 Passive Probe (Total of 1 Per Channel), Getting Started Guide, Anti-virus Software (Trial Version), Microsoft Windows Embedded Standard 7 P 64-Bit License, Commercial NIST Traceable Calibration with Certificate, Power Cable for the Destination Country, Protective Front Cover, 3-year Warranty

Included with HDO4000A-MS
 16 Channel Digital Leadset, Extra Large Gripper Probe Set (Qty. 22), Ground Extenders (Qty. 20), Flexible Ground Leads (Qty. 5)

| Memory Option | Product Code |
|---|--------------|
| 25 Mpts/ch (50 Mpts interleaved) memory | HDO4KA-L |

| Hardware Options | Product Code |
|---|----------------|
| Removable Solid State Drive Package (includes removable solid state drive kit and two solid state drives) | HDO4KA-RSSD |
| Additional Removable Solid State Drive | HDO4KA-RSSD-02 |

| General Accessories | Product Code |
|-------------------------|----------------|
| External GPIB Accessory | USB2-GPIB |
| Soft Carrying Case | HDO4K-SOFTCASE |
| Rack Mount Accessory | HDO4K-RACK |
| Accessory Pouch | HDO4K-POUCH |

| Local Language Overlays | Product Code |
|------------------------------------|-------------------|
| German Front Panel Overlay | HDO4K-FP-GERMAN |
| French Front Panel Overlay | HDO4K-FP-FRENCH |
| Italian Front Panel Overlay | HDO4K-FP-ITALIAN |
| Spanish Front Panel Overlay | HDO4K-FP-SPANISH |
| Japanese Front Panel Overlay | HDO4K-FP-JAPANESE |
| Korean Front Panel Overlay | HDO4K-FP-KOREAN |
| Chinese (Tr) Front Panel Overlay | HDO4K-FP-CHNES-TR |
| Chinese (Simp) Front Panel Overlay | HDO4K-FP-CHNES-SI |
| Russian Front Panel Overlay | HDO4K-FP-RUSSIAN |

| Product Description | Product Code |
|--------------------------------------|----------------|
| Software Options | |
| Electrical Telecom Mask Test Package | HDO4K-ET-PMT |
| Spectrum Analysis Option | HDO4K-SPECTRUM |
| Power Analysis Option | HDO4K-PWR |

| Serial Data Options | Product Code |
|--|-----------------------------|
| ARINC 429 Symbolic Decode Option | HDO4K-ARINC429bus DSymbolic |
| Audiobus Trigger and Decode Option for I ² S, LJ, RJ, and TDM | HDO4K-Audiobus TD |
| CAN, LIN and FlexRay Trigger and Decode Option | HDO4K-AUTO |
| CAN FD Trigger and Decode Option | HDO4K-CAN FDbus TD |
| CAN Trigger and Decode Option | HDO4K-CANbus TD |
| D-PHY Decode Option | HDO4K-DPHYbus D |
| DigRF 3G Decode Option | HDO4K-DigRF3Gbus D |
| DigRF v4 Decode Option | HDO4K-DigRFv4bus D |
| ENET Decode Option | HDO4K-ENETbus D |
| FlexRay Trigger and Decode Option | HDO4K-FlexRaybus TD |
| I ² C, SPI and UART Trigger and Decode Option | HDO4K-EMB |
| I ² C Bus Trigger and Decode Option | HDO4K-I2Cbus TD |
| LIN Trigger and Decode Option | HDO4K-LINbus TD |
| MDIO Decode | HDO4K-MDIObus D |
| Manchester Decode Option | HDO4K-Manchesterbus D |
| MIL-STD-1553 Trigger and Decode Option | HDO4K-1553 TD |
| NRZ Decode Option | HDO4K-NRZbus D |
| SENT Decode Option | HDO4K-SENTbus D |
| SPI Bus Trigger and Decode Option | HDO4K-SPIbus TD |
| SPMI Decode | HDO4K-SPMIbus D |
| SpaceWire Decode Option | HDO4K-SpaceWirebus D |
| UART and RS-232 Trigger and Decode Option | HDO4K-UART-RS232bus TD |
| USB 2.0 Trigger and Decode Option | HDO4K-USB2bus TD |
| USB2-HSIC Decode Option | HDO4K-USB2-HSICbus D |

ORDERING INFORMATION



| Product Description | Product Code |
|--|-----------------|
| Probes and Amplifiers | |
| 250 MHz Passive Probe for HDO4000A, 10:1, 10 M Ω | PP017 |
| 500 MHz Passive Probe 10:1, 10 M Ω | PP018 |
| 500 MHz Passive Probe, 5mm, 10:1, 10 M Ω | PP026 |
| Power/Voltage Rail Probe. 4 GHz bandwidth, 1.2x attenuation, $\pm 30V$ offset, $\pm 800mV$ | RP4030 |
| Browser for use with RP4030 | RP4000-BROWSER |
| 1,500 V, 120 MHz High-Voltage Differential Probe | HVD3106 |
| 1kV, 80 MHz High Voltage Differential Probe with 6m cable | HVD3106-6M |
| 1kV, 120 MHz High Voltage Differential Probe without tip Accessories | HVD3106-NOACC |
| 1,500 V, 25 MHz High-Voltage Differential Probe | HVD3102 |
| 1kV, 25 MHz High Voltage Differential Probe without tip Accessories | HVD3102-NOACC |
| 2kV, 120 MHz High Voltage Differential Probe | HVD3206 |
| 2kV, 80 MHz High Voltage Differential Probe with 6m cable | HVD3206-6M |
| 6kV, 100 MHz High Voltage Differential Probe | HVD3605 |
| High Voltage Fiber Optic Probe, 60 MHz (requires accessory tip) | HVFO103 |
| $\pm 1V$ (1x) Tip Accessory for HVFO103 | HVFO100-1X-TIP |
| $\pm 5V$ (5x) Tip Accessory for HVFO103 | HVFO100-5X-TIP |
| $\pm 20V$ (20x) Tip Accessory for HVFO103 | HVFO100-20X-TIP |
| 30 A; 100 MHz Current Probe – AC/DC; 30 A _{rms} ; 50 A _{peak} Pulse | CP031 |
| 30 A; 100 MHz High Sensitivity Current Probe – AC/DC; 30 A _{rms} ; 50 A _{peak} Pulse | CP031A |
| 30 A; 50 MHz Current Probe – AC/DC; 30 A _{rms} ; 50 A _{peak} Pulse | CP030 |
| 30 A; 50 MHz High Sensitivity Current Probe – AC/DC; 30 A _{rms} ; 50 A _{peak} Pulse | CP030A |
| 150 A; 10 MHz Current Probe – AC/DC; 150 A _{rms} ; 500 A _{peak} Pulse | CP150 |
| 500 A; 2 MHz Current Probe – AC/DC; 500 A _{rms} ; 700 A _{peak} Pulse | CP500 |
| Deskew Calibration Source for CP031, CP030 and AP015 | DCS015 |

| Product Description | Product Code |
|---|----------------|
| Probes and Amplifiers (cont'd) | |
| 500 MHz Differential Probe | AP033 |
| 200 MHz, 3.5 pF, 1 M Ω Active Differential Probe, $\pm 20 V$, 60V common-mode | ZD200 |
| 1 GHz, 1.0 pF, 1 M Ω Active Differential Probe, $\pm 8 V$, 10V common-mode | ZD1000 |
| 1.5 GHz, 1.0 pF, 1 M Ω Active Differential Probe, $\pm 8 V$, 10V common-mode | ZD1500 |
| 1 GHz, 0.9 pF, 1 M Ω High Impedance Active Probe | ZS1000 |
| Set of 4 ZS1000 | ZS1000-QUADPAK |
| 1.5 GHz, 0.9 pF, 1 M Ω High Impedance Active Probe | ZS1500 |
| Set of 4 ZS1500 | ZS1500-QUADPAK |
| 1 Ch, 100 MHz Differential Amplifier with Precision Voltage Source | DA1855A |
| 100:1 or 10:1 Selectable, 250 MHz Passive Diff. Probe Pair | DXC100A |
| 1:1, 50 MHz Passive Differential Probe Pair | DXC200 |
| 100:1, 250 MHz, 2.5kV High Voltage Probe Pair | DXC5100 |
| 10x, 1 M Ω Passive Attenuator for DXC Series Probes | DA101 |
| 100:1 400 MHz 50 M Ω 1 kV High-voltage Probe | HVP120 |
| 100:1 400 MHz 50 M Ω 4 kV High-voltage Probe | PPE4KV |
| 1000:1 400 MHz 50 M Ω 5 kV High-voltage Probe | PPE5KV |
| 1000:1 400 MHz 50 M Ω 6 kV High-voltage Probe | PPE6KV |
| TekProbe to ProBus Probe Adapter | TPA10 |
| Set of 4 TPA10 TekProbe to ProBus Probe Adapters. | TPA10-QUADPAK |
| Programmable Current Sensor to ProBus Adapter for use with third party current sensors | CA10 |
| Set of 4 CA10 Programmable Current Sensor to ProBus Adapters for use with third party current sensors | CA10-QUADPAK |

Customer Service

Teledyne LeCroy oscilloscopes and probes are designed, built, and tested to ensure high reliability. In the unlikely event you experience difficulties, our digital oscilloscopes are fully warranted for three years and our probes are warranted for one year. This warranty includes:

- No charge for return shipping
- Long-term 7-year support
- Upgrade to latest software at no charge



1-800-5-LeCroy
teledynelecroy.com

Local sales offices are located throughout the world.
Visit our website to find the most convenient location.

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for [Benchtop Oscilloscopes](#) category:

Click to view products by [Teledyne](#) manufacturer:

Other Similar products are found below :

[WSXS-RACK](#) [WSXS-MOUSE](#) [WSXS-KYBD](#) [UPO2102CS](#) [AX-DS1100CFM](#) [TT-HV250](#) [TT-LF212](#) [TT-LF 312-2-6](#) [DSO3064-KIT-IV](#)
[DSO5102P](#) [DSO5202B](#) [RT-ZP03](#) [MSO5062D](#) [CC-650](#) [FLUKE PM9082/001](#) [TOS-2020CT](#) [PK007-003](#) [PK007-019](#) [PK007-022](#) [PK007-024](#)
[PK007-026](#) [PK106-5](#) [PK116-3](#) [PK1-5MM-102](#) [PK1-5MM-104](#) [PK1-5MM-105](#) [PK1-5MM-108](#) [PK1-5MM-111](#) [PK1-5MM-112](#) [PK1-5MM-](#)
[113](#) [PK1-5MM-120](#) [TA041](#) [GDS-1052-U](#) [GDS-1072A-U](#) [GDS-1102A-U](#) [GDS-2072A](#) [GDS-2202E](#) [GDS-2204E](#) [U3400A-1CM](#) [PP-150](#) [PP-](#)
[80](#) [HO720](#) [TT-MF312](#) [TT-LF316](#) [TT-HV150](#) [TT-HF212RA](#) [TT-HF212](#) [2555](#) [2557](#) [2566](#)